



www.jdsemi.cn

深圳市晶导电子有限公司  
ShenZhen Jingdao Electronic Co.,Ltd.

CL60R180F

# CL60R180F

## 600V N-Channel Super Junction MOSFET

### Features

- Very Low FOM ( $R_{DS(on)} \times Q_g$ )
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode

### Applications

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- TV power & LED Lighting Power
- AC to DC Converters
- Telecom

### Key Parameters

Parameter	Value	Unit
$BV_{DSS}$	600	V
$I_D$	20.0	A
$R_{DS(on)(MAX)}$	0.180	$\Omega$
$Q_{g,Typ}$	50	nC

### Package & Internal Circuit

TO-220F	SYMBOL

### Absolute Maximum Ratings

 $T_C = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-Source Voltage	600	V
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$I_D$	Drain Current - Continuous ( $T_C = 25^\circ\text{C}$ )	20.0	A
	Drain Current - Continuous ( $T_C = 100^\circ\text{C}$ )	12.0	A
$I_{DM}^{(1)}$	Drain Current - Pulsed	60	A
$E_{AS}^{(2)}$	Single Pulsed Avalanche Energy	316	mJ
$I_{AR}$	Avalanche Current	2.7	A
$dv/dt$	MOSFET $dv/dt$ ruggedness, $V_{DS}=0\dots 400\text{V}$	50	V/ns
$dv/dt$	Reverse diode $dv/dt$ , $V_{DS}=0\dots 400\text{V}$ , $IDS \leq ID$	15	V/ns
$P_D$	Power Dissipation ( $T_C = 25^\circ\text{C}$ )	40	W
$V_{ESD(G-S)}$	Gate source ESD(HBM-C=100pF, $R=1.5\text{K}\Omega$ )	2000	V
$T_j$ , $T_{stg}$	Operating and Storage Temperature Range	-55 to +150	°C

### Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	3.12	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	80	°C/W



www.jdsemi.cn

深圳市晶导电子有限公司  
ShenZhen Jingdao Electronic Co.,Ltd.

CL60R180F

**Electrical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
<b>On-Characteristics</b>						
$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.0		4.0	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 10 \text{ A}$		0.15	0.18	$\Omega$
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 1 \text{ mA}$	600			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 600 \text{ V}$ , $V_{GS} = 0$			1	$\mu\text{A}$
		$V_{DS} = 600 \text{ V}$ , $T_C = 150^\circ\text{C}$			100	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 30 \text{ V}$ , $V_{DS} = 0 \text{ V}$			$\pm 1$	$\mu\text{A}$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 400 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$		2180		pF
$C_{oss}$	Output Capacitance			47		pF
$C_{rss}$	Reverse Transfer Capacitance			3.5		pF
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Time	$V_{DS} = 325 \text{ V}$ , $I_D = 10 \text{ A}$ , $R_G = 25 \Omega$ (Note 3,4)		45		ns
$t_r$	Turn-On Rise Time			23		ns
$t_{d(off)}$	Turn-Off Delay Time			201		ns
$t_f$	Turn-Off Fall Time			18		ns
$Q_g$	Total Gate Charge	$V_{DS} = 520 \text{ V}$ , $I_D = 10 \text{ A}$ , $V_{GS} = 10 \text{ V}$ (Note 3,4)		50		nC
$Q_{gs}$	Gate-Source Charge			10		nC
$Q_{gd}$	Gate-Drain Charge			14		nC

#### Drain-Source Diode Characteristics and Maximum Ratings

$I_S$	Maximum Continuous Drain-Source Diode Forward Current			20	A
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current			61	A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}$ , $I_S = 20 \text{ A}$		1.3	V
$trr$	Reverse Recovery Time	$V_R = 400 \text{ V}$ , $I_F = 10 \text{ A}$ $dI_F/dt = 100 \text{ A}/\mu\text{s}$		370	ns
$Qrr$	Reverse Recovery Charge			5.0	$\mu\text{C}$

#### Notes :

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=2.7\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
- Pulse Test : Pulse Width  $\leq 300 \mu\text{s}$ , Duty Cycle  $\leq 2\%$
- Essentially Independent of Operating Temperature

### Typical Characteristics

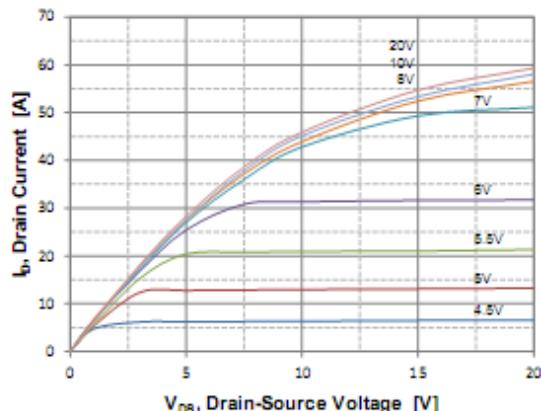


Figure 1. On Region Characteristics

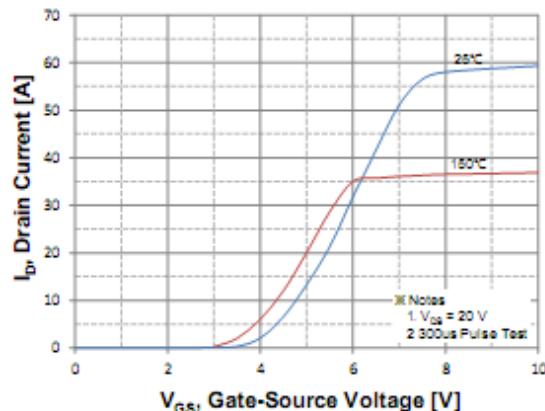


Figure 2. Transfer Characteristics

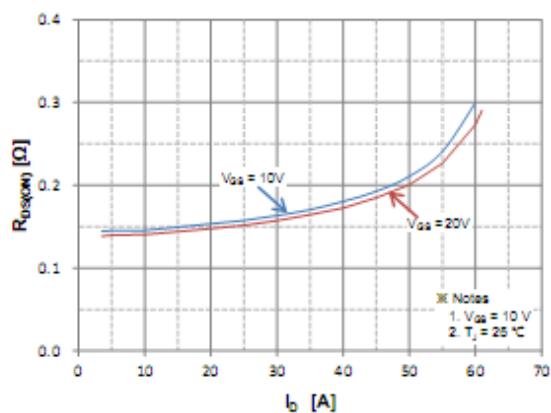


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

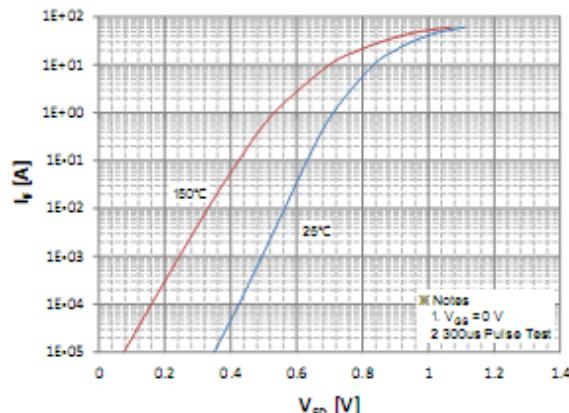


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

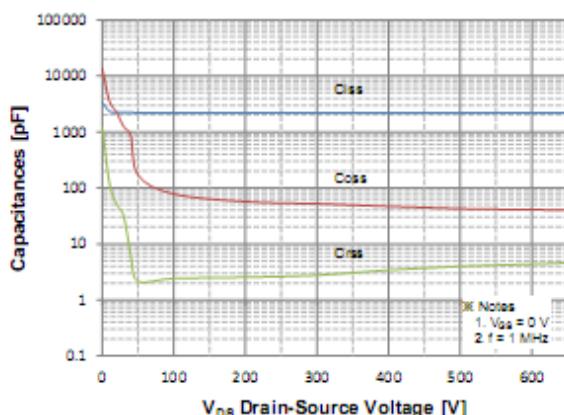


Figure 5. Capacitance Characteristics

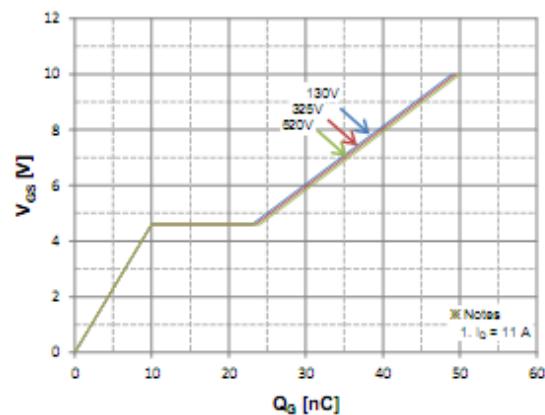
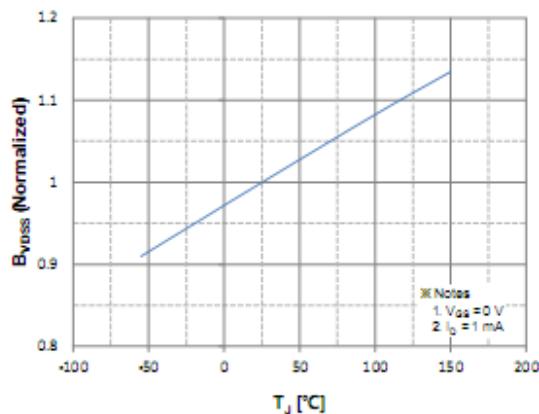
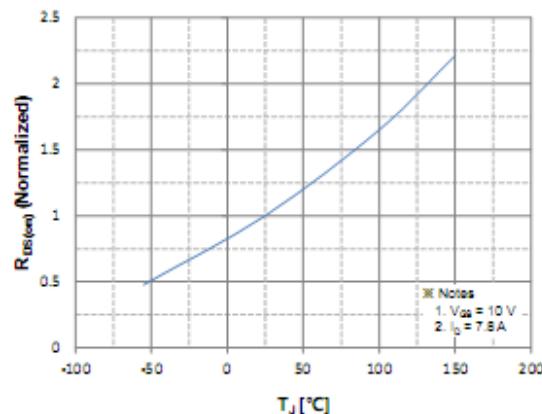


Figure 6. Gate Charge Characteristics

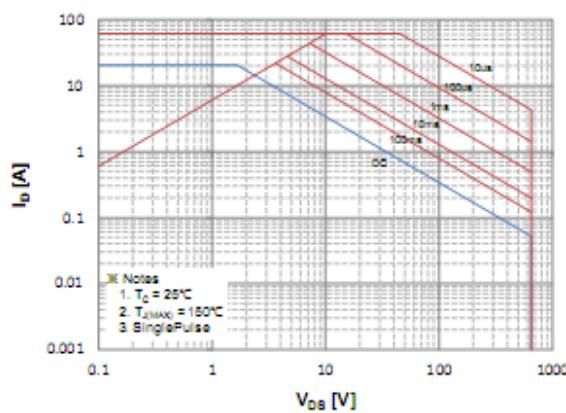
### Typical Characteristics



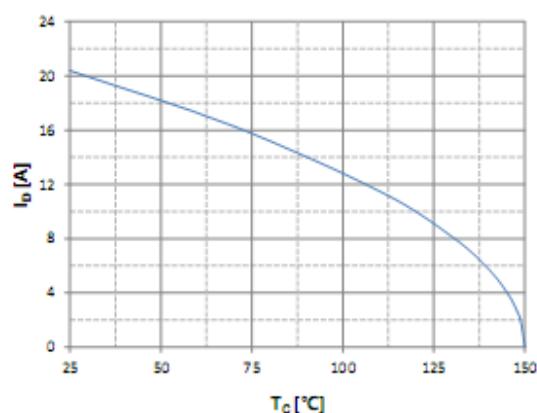
**Figure 7. Breakdown Voltage Variation vs. Temperature**



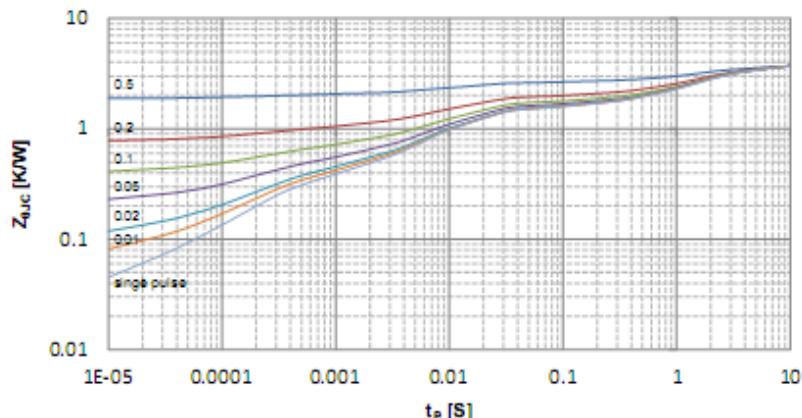
**Figure 8. On-Resistance Variation vs. Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs. Case Temperature**



**Figure 11. Transient Thermal Response Curve**

Fig 12. Gate Charge Test Circuit & Waveform

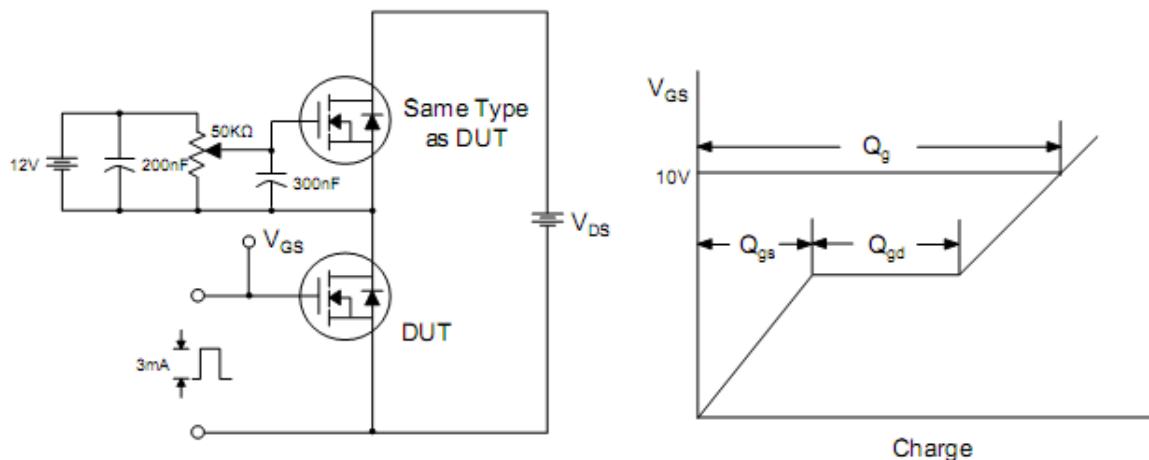


Fig 13. Resistive Switching Test Circuit & Waveforms

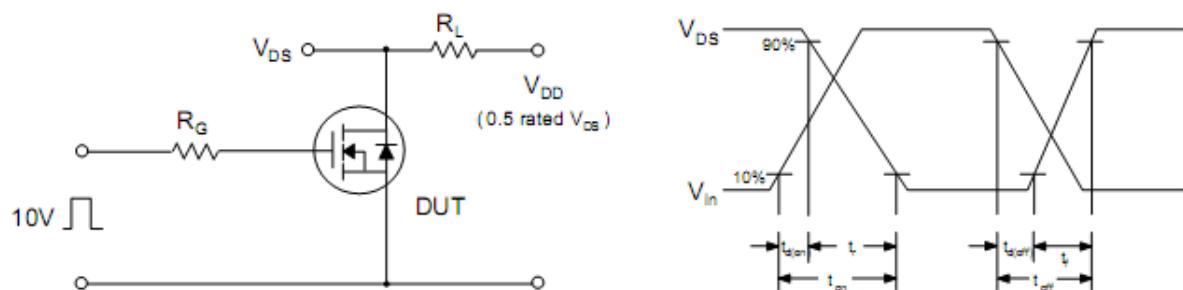


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

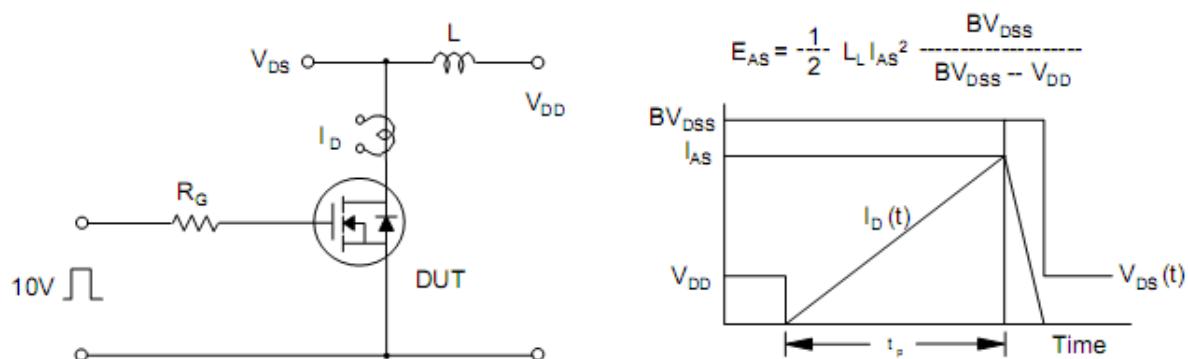
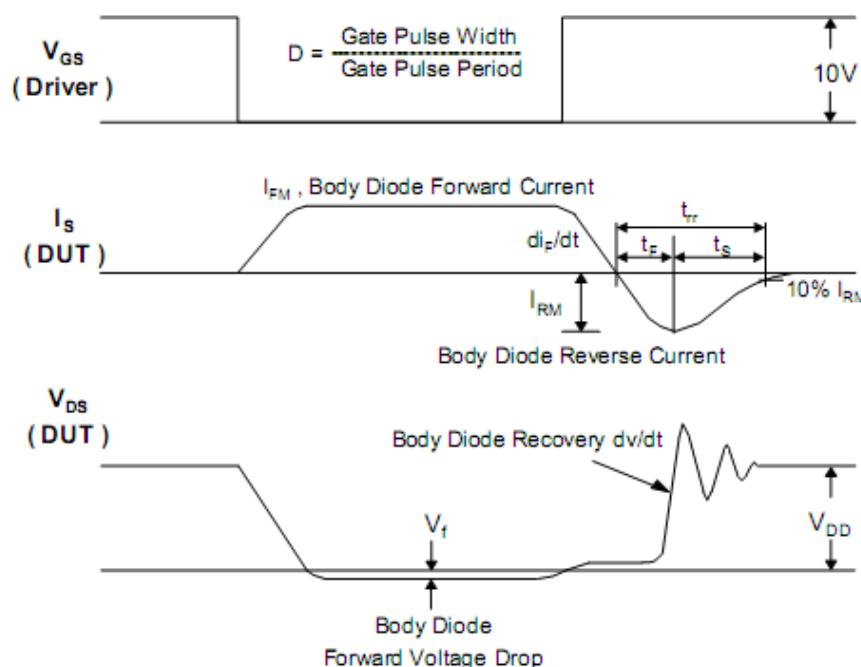
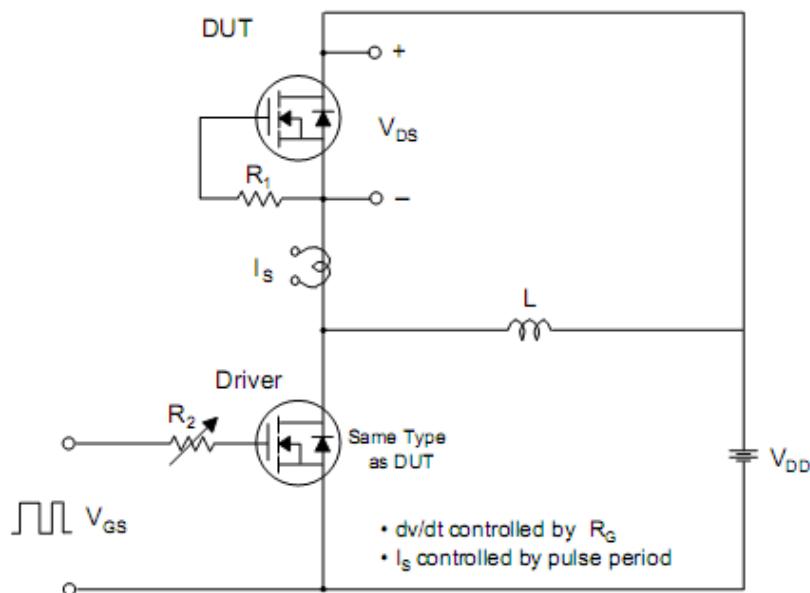


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





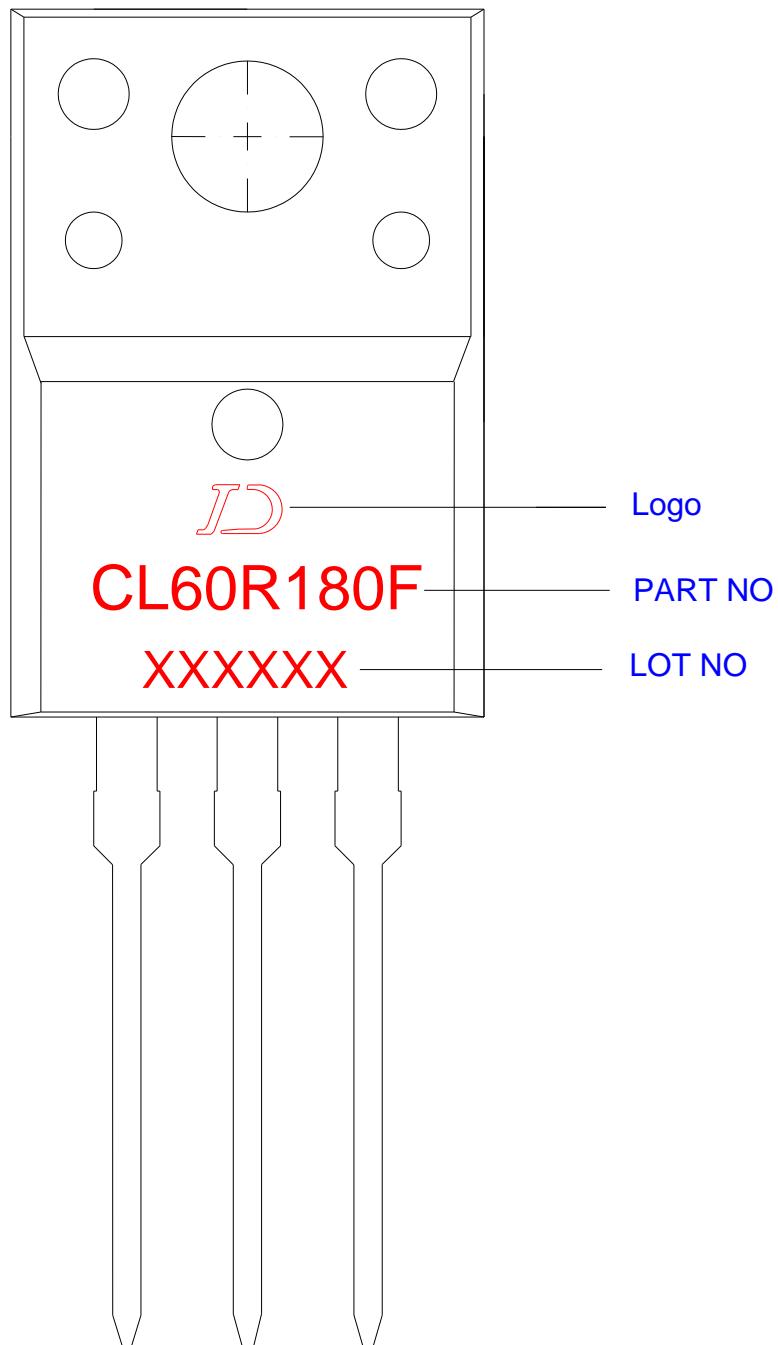
www.jdsemi.cn

深圳市晶导电子有限公司  
ShenZhen Jingdao Electronic Co.,Ltd.

CL60R180F

---

### Marking





www.jdsemi.cn

深圳市晶导电子有限公司  
ShenZhen Jingdao Electronic Co.,Ltd.

CL60R180F

Package Dimension (Unit: mm)

TO-220F

